



# PERRY JOHNSON LABORATORY ACCREDITATION, INC.

## *Certificate of Accreditation*

*Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:*

***Advanced Measurement Labs, Inc.***  
15840 West Monte Street, Suite B-109, Sylmar, CA 91342

*(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:*

**ISO/IEC 17025:2005**

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated January 2009):

***Dimensional Inspection***  
*(As detailed in the supplement)*

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

*Initial Accreditation Date:*

January 20, 2017

*Issue Date:*

January 20, 2017

*Expiration Date:*

March 31, 2019

Tracy Szerszen  
President/Operations Manager

*Accreditation No.:*

93108

*Certificate No.:*

L17-28

Perry Johnson Laboratory  
Accreditation, Inc. (PJLA)  
755 W. Big Beaver, Suite 1325  
Troy, Michigan 48084

*The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: [www.pjilabs.com](http://www.pjilabs.com)*



# Certificate of Accreditation: Supplement

## Advanced Measurement Labs, Inc. / Advanced Measurement Machines, Inc.

15840 West Monte Street, Suite B-109, Sylmar, CA 91342

Contact: Bipin Mukherji Phone: 818-833-7779

*Accreditation is granted to the facility to perform the following testing:*

FIELD OF TEST	ITEMS, MATERIALS OR PRODUCTS TESTED	SPECIFIC TESTS OR PROPERTIES MEASURED	SPECIFICATION, STANDARD METHOD OR TECHNIQUE USED	RANGE (WHERE APPROPRIATE) AND DETECTION LIMIT
Dimensional Inspection <sup>F</sup>	Customer Supplied Product	Dimensional Inspection	ASME Y14.5-2009 Zeiss CMM Micro-Vu Excel	(700 mm x 1 000 mm x 600) mm D.L. = 4 μm

1. The presence of a superscript F means that the laboratory performs testing of the indicated parameter at its fixed location. Example: Outside Micrometer<sup>F</sup> would mean that the laboratory performs this testing at its fixed location.

